





SN74LV595A

SCLS414T - APRIL 1998 - REVISED MARCH 2023

SN74LV595A 8-Bit Shift Registers With 3-State Output Registers

1 Features

Texas

V_{CC} operation of 2 V to 5.5 V

INSTRUMENTS

- Maximum t_{pd} of 7.1 ns at 5 V
- Typical V_{OLP} (output ground bounce) < 0.8 V at V_{CC} = 3.3 V, T_A = 25°C
- Typical V_{OHV} (output V_{OH} undershoot)
 > 2.3 V at V_{CC} = 3.3 V, T_A = 25°C
- Support mixed-mode voltage operation on all ports
- · 8-bit serial-in, parallel-out shift
- I_{off} supports live insertion, partial power-down mode, and back-drive protection
- · Shift register has direct clear
- Latch-up performance exceeds 250 mA per JESD 17

2 Applications

- Output expansion
- LED matrix control
- 7-segment display control

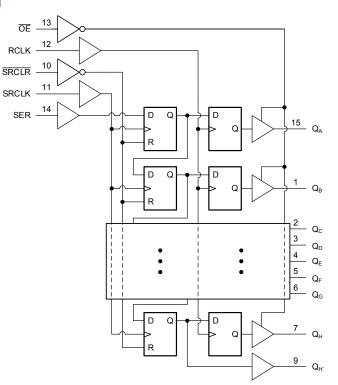
3 Description

The SN74LV595A device contains an 8-bit serial-in, parallel-out shift register that feeds an 8-bit D-type storage register. Both the shift register clock (SRCLK) and storage register clock (RCLK) are positive-edge triggered.

PART NUMBER	PACKAGE	BODY SIZE (NOM)				
SN74LV595A	RGY (VQFN, 16)	4.00 mm × 3.50 mm				
	PW (TSSOP, 16)	5.00 mm × 4.40 mm				
	NS (SO, 16)	10.20 mm × 5.30 mm				
	D (SOIC, 16)	9.00 mm × 3.90 mm				
	BQB (WQFN, 16)	3.60 mm × 2.60 mm				

Package Information⁽¹⁾

(1) For all available packages, see the orderable addendum at the end of the data sheet.



Logic Diagram (Positive Logic)



An IMPORTANT NOTICE at the end of this data sheet addresses availability, warranty, changes, use in safety-critical applications, intellectual property matters and other important disclaimers. UNLESS OTHERWISE NOTED, this document contains PRODUCTION DATA.



Table of Contents

2 3	Features Applications Description	.1 1
	Revision History Pin Configuration and Functions	
	Specifications	
Č	6.1 Absolute Maximum Ratings	
	6.2 ESD Ratings	
	6.3 Recommended Operating Conditions	
	6.4 Thermal Information	5
	6.5 Electrical Characteristics	6
	6.6 Timing Requirements, V_{CC} = 2.5 V ± 0.2 V	
	6.7 Timing Requirements, V_{CC} = 3.3 V ± 0.3 V	
	6.8 Timing Requirements, V_{CC} = 5 V ± 0.5 V	
	6.9 Switching Characteristics, V_{CC} = 2.5 V ± 0.2 V	
	6.10 Switching Characteristics, V_{CC} = 3.3 V ± 0.3 V	
	6.11 Switching Characteristics, V_{CC} = 5 V ± 0.5 V	.9
	6.12 Noise Characteristics	
	6.13 Operating Characteristics	
	6.14 Typical Characteristics	10

7 Parameter Measurement Information	11
8 Detailed Description	.12
8.1 Overview	
8.2 Functional Block Diagram	12
8.3 Feature Description.	
8.4 Device Functional Modes	
9 Application and Implementation	16
9.1 Application Information	
9.2 Typical Application	
9.3 Power Supply Recommendations	
9.4 Layout	
10 Device and Documentation Support	
10.1 Documentation Support	
10.2 Receiving Notification of Documentation Updates.	
10.3 Support Resources	
10.4 Trademarks	
10.5 Electrostatic Discharge Caution	
10.6 Glossary	
11 Mechanical, Packaging, and Orderable	
Information	20

4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision S (November 2022) to Revision T (March 2023)	Page
 Updated the structural layout of document to current standard Updated thermal values for NS package from RθJA = 79.4 to 110.8, RθJC(top) = 35.8 to 72, 72.6, ΨJT = 5.5 to 39.7, ΨJB = 39.9 to 72.3, all values in °C/W 	RθJB = 40.2 to
Changes from Revision R (June 2022) to Revision S (November 2022)	Page

•	Changed the status of the data sheet from: Advanced Information to: Production Data	1
---	---	---



NAME GND ŌĒ Q_A QB Q_C Q_D QE Q_F Q_G Q_H Q_{H'} RCLK

SER

 V_{CC}

SRCLK

SRCLR

Thermal Pad

5 Pin Configuration and Functions

1 O	16	UCC Vcc
2	15	Q_A
3	14	💷 SER
4	13	
5	12	
6	11	
7	10	
8	9	D Q _H
	3 4 5 6 7	2 15 3 14 4 13 5 12 6 11 7 10

Figure 5-1. D, DW, or PW Package, 16-Pin SOIC, SOP or TSSOP (Top View)

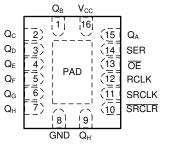


Figure 5-2. BQB or RGY Package, 16-Pin WQFN or VQFN (Transparent Top View)

PIN	TYPE ⁽¹⁾	DESCRIPTION
NO.	ITFE	DESCRIPTION
8	G	Ground Pin
13	I	Output Enable Pin. Active LOW
15	0	Q _A Output
1	0	Q _B Output
2	0	Q _C Output
3	0	Q _D Output
4	0	Q _E Output
5	0	Q _F Output
6	0	Q _G Output
7	0	Q _H Output
9	0	Q _H Output
12	I	RCLK Input

SER Input

SRCLK Input

SRCLR Input

Thermal Pad⁽²⁾

Power Pin

L

L

L Ρ

Table 5-1. Pin Functions

I = Input, O = Output, I/O = Input or Output, G = Ground, P = Power (1)

14

11

10

16

(2) RGY and BQB package only



6 Specifications 6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

			MIN	MAX	UNIT
V _{CC}	Supply voltage range		-0.5	7	V
VI	Input voltage range ⁽²⁾		-0.5	7	V
Vo	Voltage range applied to any output in the high-impedance or power-off state ⁽²⁾		-0.5	7	V
Vo	Output voltage range applied in the high or low state ⁽²⁾ (3)	-0.5	V _{CC} + 0.5	V	
l _{IK}	Input clamp current V _I < 0			-20	mA
I _{OK}	Output clamp current	V _O < 0		-50	mA
lo	Continuous output current	$V_{O} = 0$ to V_{CC}		±35	mA
	Continuous current through V _{CC} or GND	·		±70	mA
T _{stg}	Storage temperature range		-65	150	°C

(1) Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) The input and output negative-voltage ratings may be exceeded if the input and output current ratings are observed.

(3) This value is limited to 5.5-V maximum.

6.2 ESD Ratings

			VALUE	UNIT
		Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾	±2000	
V _(ESD)	Electrostatic discharge	Machine Model (MM), per JEDEC specification	±200	V
		Charged-device model (CDM), per ANSI/ESDA/JEDEC JS-002 ⁽²⁾	±1000	

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.



6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

			MIN	MAX	UNIT	
V _{CC}	Supply voltage		2	5.5	V	
		V _{CC} = 2 V	1.5			
V	High-level input voltage	V_{CC} = 2.3 V to 2.7 V	V _{CC} × 0.7		V	
V _{IH}	nigh-level liiput voltage	V _{CC} = 3 V to 3.6 V	V _{CC} × 0.7		v	
		V_{CC} = 4.5 V to 5.5 V	V _{CC} × 0.7			
		V _{CC} = 2 V		0.5		
V	Low-level input voltage	V_{CC} = 2.3 V to 2.7 V		V _{CC} × 0.3	V	
V _{IL}	Low-level input voltage	V _{CC} = 3 V to 3.6 V		V _{CC} × 0.3		
		V_{CC} = 4.5 V to 5.5 V		$V_{CC} \times 0.3$		
VI	Input voltage		0	5.5	V	
Vo	Output voltage	High or low state	0	V _{CC}	V	
		3-state	0	5.5		
	High-level output current	V _{CC} = 2 V		-50	μA	
		V_{CC} = 2.3 V to 2.7 V		-2		
I _{OH}		V _{CC} = 3 V to 3.6 V		-8	mA	
		V_{CC} = 4.5 V to 5.5 V		-16		
		V _{CC} = 2 V		50	μA	
	Low-level output current	V_{CC} = 2.3 V to 2.7 V		2		
I _{OL}		V _{CC} = 3 V to 3.6 V		8	mA	
		V_{CC} = 4.5 V to 5.5 V		16		
		V_{CC} = 2.3 V to 2.7 V		200		
Δt/Δv	Input transition rise or fall rate	V _{CC} = 3 V to 3.6 V		100	ns/V	
		V _{CC} = 4.5 V to 5.5 V		20		
T _A	Operating free-air temperature		-40	125	°C	

 All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs.

6.4 Thermal Information

				SN74L	V595A			
	THERMAL METRIC ⁽¹⁾		D DB NS PW RO		RGY	BQB	UNIT	
		16 PINS	16 PINS	16 PINS	16 PINS	16 PINS	16 PINS	
R _{0JA}	Junction-to-ambient thermal resistance	80.2	97.8	110.8	131.2	39.5	85.9	
R _{0JC(top)}	Junction-to-case (top) thermal resistance	40.3	48.1	72	69.4	50.5	82.4	
R _{θJB}	Junction-to-board thermal resistance	38.0	48.5	72.6	75.8	17.1	55.6	°C/W
Ψ _{JT}	Junction-to-top characterization parameter	9.0	10.0	39.7	21	0.9	9.4	- C/W
Ψ _{JB}	Junction-to-board characterization parameter	37.7	47.9	72.3	75.4	17.2	55.6	
R _{0JC(bot)}	Junction-to-case (bottom) thermal resistance	N/A	N/A	N/A	N/A	5.9	33.3	

(1) For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report (SPRA953).



6.5 Electrical Characteristics

DADAMETED	TEST CONDITIONS			-40°	C to 85°C	-40	–40°C to 125°C		
PARAMETER			V _{cc}	MIN	TYP M	X MIN	TYP I	ЛАХ	UNIT
		I _{OH} = -50 μA	2 V to 5.5 V	V _{CC} - 0.1		V _{CC} – 0.1			
		I _{OH} = -2 mA	2.3 V	2		2			
V	Q _{H'}	I _{OH} = -6 mA	3 V	2.48		2.45			V
V _{OH}	Q _A –Q _H	I _{OH} = -8 mA	3 V	2.48		2.45			v
	Q _{H'}	I _{OH} = -12 mA	4.5 V	3.8		3.7			
	Q _A –Q _H	I _{OH} = -16 mA	- 4.5 V	3.8		3.7			1
		I _{OL} = 50 μA	2 V to 5.5 V		(.1		0.1	
		I _{OL} = 2 mA	2.3 V		(.4		0.4	
V	Q _{H'}	I _{OL} = 6 mA	- 3 V		0.	14		0.5	V
V _{OL}	Q _A -Q _H	I _{OL} = 8 mA			0.	14		0.5	v
	Q _{H'}	I _{OL} = 12 mA	4.5 V		0.	55		0.6	
	Q _A -Q _H	I _{OL} = 16 mA	- 4.5 V		0.	55		0.6	
I _I	V _I = 5.5 V or GND		0 V to 5.5 V			±1		±1	μA
I _{OZ}	$V_0 = V_{CC}$ or GND	$Q_A - Q_H$	5.5 V			±5		±5	μA
I _{CC}	$V_I = V_{CC}$ or GND	I _O = 0	5.5 V			20		20	μA
l _{off}	$V_{\rm I}$ or $V_{\rm O}$ = 0 to 5.5	V	0 V			5		5	μA
C _i	$V_I = V_{CC}$ or GND		3.3 V		3.5		3.5		pF

over recommended operating free-air temperature range (unless otherwise noted)

6.6 Timing Requirements, V_{CC} = 2.5 V ± 0.2 V

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 7-1)

			T _A = 25	°C	–40°C to	85°C	–40°C to 1	25°C	UNIT
				MAX	MIN	MAX	MIN	MAX	UNIT
		SRCLK high or low	7		7.5		8.5		
t _w Pulse duration	RCLK high or low	7		7.5		8.5		ns	
	SRCLR low	6		6.5		7.5			
		SER before SRCLK↑	5.5		5.5		6.5		
		SRCLK↑ before RCLK↑ ⁽¹⁾	8		9		10		
t _{su}	Setup time	SRCLR low before RCLK↑	8.5		9.5		10.5		ns
		SRCLR high (inactive) before SRCLK↑	4		4		5		
t _h	Hold time	SER after SRCLK↑	1.5		1.5		2.5		ns

(1) This setup time allows the storage register to receive stable data from the shift register. The clocks can be tied together, in which case the shift register is one clock pulse ahead of the storage register.



6.7 Timing Requirements, V_{CC} = 3.3 V ± 0.3 V

			T _A = 25	°C	–40°C to	85°C	–40°C to 125°C		UNIT	
			MIN	MAX	MIN MAX		MIN MAX		UNIT	
		SRCLK high or low	5.5		5.5		6.5			
tw	Pulse duration	RCLK high or low	5.5		5.5		6.5		ns	
	SRCLR low	5		5		6				
		SER before SRCLK↑	3.5		3.5		4.5			
		SRCLK↑ before RCLK↑ ⁽¹⁾	8		8.5		9.5			
t _{su}	Setup time	SRCLR low before RCLK↑	8		9		10		ns	
		SRCLR high (inactive) before SRCLK↑	3		3		4			
t _h	Hold time	SER after SRCLK↑	1.5		1.5		2.5		ns	

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 7-1)

(1) This setup time allows the storage register to receive stable data from the shift register. The clocks can be tied together, in which case the shift register is one clock pulse ahead of the storage register.

6.8 Timing Requirements, V_{CC} = 5 V ± 0.5 V

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 7-1)

			T _A = 25	°C	-40°C to 8	35°C	-40°C to 1	25°C	
			MIN	MAX	MIN	MAX	MIN	MAX	UNIT
		SRCLK high or low	5		5		6		
tw	Pulse duration	RCLK high or low	5		5		6		ns
		SRCLR low	5.2		5.2		6.2		
		SER before SRCLK↑	3		3		4		
		SRCLK↑ before RCLK↑ ⁽¹⁾	5		5		6		
t _{su}	Setup time	SRCLR low before RCLK↑	5		5		6		ns
		SRCLR high (inactive) before SRCLK↑	2.5		2.5		3.5		
t _h	Hold time	SER after SRCLK↑	2		2		3		ns

(1) This setup time allows the storage register to receive stable data from the shift register. The clocks can be tied together, in which case the shift register is one clock pulse ahead of the storage register.

6.9 Switching Characteristics, V_{CC} = 2.5 V \pm 0.2 V

over recommended operating free-air temperature range (unless otherwise noted) ((see Figure 7-1)	

DADAMETED	FROM	то	LOAD	Т	_A = 25°C		–40°C to	85°C	–40°C to 1	25°C	LINUT
PARAMETER	(INPUT)	(OUTPUT)	CAPACITANCE	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
£			C _L = 15 pF	65	80		45		45		MHz
f _{max}			C _L = 50 pF	60	70		40		40		INILIZ
t _{PLH}	RCLK	Q _A Q _H			8.4	14.2	1	15.8	1	16.8	
t _{PHL}	ROLK				8.4	14.2	1	15.8	1	16.8	
t _{PLH}	SRCLK	Q _{H'}			9.4	19.6	1	22.2	1	23.2	
t _{PHL}	SILCER	QH'			9.4	19.6	1	22.2	1	23.2	
t _{PHL}	SRCLR	Q _H '	C _L = 15 pF		8.7	14.6	1	16.3	1	17.3	ns
t _{PZH}	ŌĒ	Q _A – Q _H			8.2	13.9	1	15	1	16	
t _{PZL}					10.9	18.1	1	20.3	1	21.3	
t _{PHZ}	ŌĒ	Q _A – Q _H			8.3	13.7	1	15.6	1	16.6	
t _{PLZ}	OL				9.2	15.2	1	16.7	1	17.7	
t _{PLH}	RCLK	Q _A – Q _H			11.2	17.2	1	19.3	1	21.3	
t _{PHL}	NCER				11.2	17.2	1	19.3	1	21.3	
t _{PLH}	SRCLK	Q _{H'}			13.1	22.5	1	25.5	1	27.5	
t _{PHL}	SILCER	QH'			13.1	22.5	1	25.5	1	27.5	
t _{PHL}	SRCLR	Q _H '	C _L = 50 pF		12.4	18.8	1	21.1	1	23.1	ns
t _{PZH}	ŌĒ	0.0			10.8	17	1	18.3	1	20.3	
t _{PZL}	0E	Q _A – Q _H			13.4	21	1	23	1	25	
t _{PHZ}	ŌĒ				12.2	18.3	1	19.5	1	21.5	
t _{PLZ}	0E	Q _A – Q _H			14	20.9	1	22.6	1	24.6	

6.10 Switching Characteristics, V_{CC} = 3.3 V \pm 0.3 V

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 7-1)

DADAMETED	FROM	то	LOAD	T,	_A = 25°C		-40°C to	85°C	–40°C to 1	25°C	
PARAMETER	(INPUT)	(OUTPUT)	CAPACITANCE	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
£			C _L = 15 pF	80	120		70		70		MHz
f _{max}			C _L = 50 pF	55	105		50		50		IVITIZ
t _{PLH}	RCLK	0.0			6	11.9	1	13.5	1	14.5	
t _{PHL}	KOLK	Q _A – Q _H			6	11.9	1	13.5	1	14.5	
t _{PLH}	SRCLK	Q _{H'}			6.6	13	1	15	1	16	
t _{PHL}	SKOLK				6.6	13	1	15	1	16	
t _{PHL}	SRCLR	Q _{H'}	C _L = 15 pF		6.2	12.8	1	13.7	1	14.7	ns
t _{PZH}	ŌĒ	Q _A – Q _H			6	11.5	1	13.5	1	14.5	
t _{PZL}					7.8	11.5	1	13.5	1	14.5	
PHZ	ŌĒ	0.0			6.1	14.7	1	15.2	1	16.2	
t _{PLZ}	0L	Q _A – Q _H			6.3	14.7	1	15.2	1	16.2	
t _{PLH}	RCLK	Q _A – Q _H			7.9	15.4	1	17	1	19	
t _{PHL}	NOLK				7.9	15.4	1	17	1	19	
t _{PLH}	SRCLK	Q _{H'}			9.2	16.5	1	18.5	1	20.5	
t _{PHL}	SKOLK				9.2	16.5	1	18.5	1	20.5	
t _{PHL}	SRCLR	Q _H ,	C _L = 50 pF		9	16.3	1	17.2	1	19.2	ns
t _{PZH}	ŌĒ	0.0]		7.8	15	1	17	1	19	
t _{PZL}	UE	Q _A – Q _H			9.6	15	1	17	1	19	1
t _{PHZ}	<u>a</u> e	0.0	1		8.1	15.7	1	16.2	1	18.2	
t _{PLZ}	ŌĒ	Q _A – Q _H			9.3	15.7	1	16.2	1	18.2	



6.11 Switching Characteristics, V_{CC} = 5 V \pm 0.5 V

DADAMETED	FROM	то	LOAD	T	T _A = 25°C -4		–40°C to	85°C	–40°C to 12	25°C	UNIT
PARAMETER	(INPUT)	(OUTPUT)	CAPACITANCE	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNII
f			C _L = 15 pF	135	170		115		115		MHz
f _{max}			C _L = 50 pF	120	140		95		95		IVITIZ
t _{PLH}	RCLK	0.0			4.3	7.4	1	8.5	1	9.5	
t _{PHL}	ROLK	Q _A –Q _H			4.3	7.4	1	8.5	1	9.5	
t _{PLH}	SRCLK	0			4.5	8.2	1	9.4	1	10.4	
t _{PHL}	SKULK	Q _H '			4.5	8.2	1	9.4	1	10.4	
t _{PHL}	SRCLR	Q _H ,	C _L = 15 pF		4.5	8	1	9.1	1	10.1	ns
t _{PZH}	ŌĒ	0.0			4.3	8.6	1	10	1	11	
t _{PZL}	UE	Q _A –Q _H			5.4	8.6	1	10	1	11	
t _{PHZ}	ŌĒ	Q _A –Q _H			2.4	6	1	7.1	1	7.1	
t _{PLZ}	OL	QA-QH			2.7	5.1	1	7.2	1	7.2	
t _{PLH}	RCLK	Q _A –Q _H			5.6	9.4	1	10.5	1	12.5	
t _{PHL}	NOEK	QA-QH			5.6	9.4	1	10.5	1	12.5	
t _{PLH}	SRCLK	Q _H ,			6.4	10.2	1	11.4	1	13.4	
t _{PHL}	SILCER	QH'			6.4	10.2	1	11.4	1	13.4	
t _{PHL}	SRCLR	Q _H ,	C _L = 50 pF		6.4	10	1	11.1	1	13.1	ns
t _{PZH}	ŌĒ	0.0			5.7	10.6	1	12	1	14	
t _{PZL}		Q _A –Q _H			6.8	10.6	1	12	1	14	
t _{PHZ}	ŌĒ	0.0			3.5	10.3	1	11	1	13	
t _{PLZ}	UE	Q _A –Q _H			3.4	10.3	1	11	1	13	

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 7-1)

6.12 Noise Characteristics

V_{CC} = 3.3 V, C_L = 50 pF, T_A = 25°C⁽¹⁾

	PARAMETER	MIN	TYP	MAX	UNIT
V _{OL(P)}	Quiet output, maximum dynamic V _{OL}		0.3		V
V _{OL(V)}	Quiet output, minimum dynamic V _{OL}		-0.2		V
V _{OH(V)}	Quiet output, minimum dynamic V _{OH}		2.8		V
V _{IH(D)}	High-level dynamic input voltage	2.31			V
V _{IL(D)}	Low-level dynamic input voltage			0.99	V

(1) Characteristics are for surface-mount packages only.

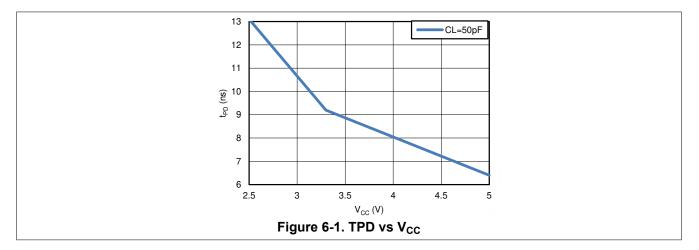
6.13 Operating Characteristics

T_A = 25°C

	PARAMETER	TEST	CONDITIONS	V _{cc}	TYP	UNIT
C	Power dissipation capacitance	C ₁ = 50 pF,	f = 10 MHz	3.3 V	111	'nE
Cpd	Power dissipation capacitance	CL - 50 pF,		5 V	114	pF

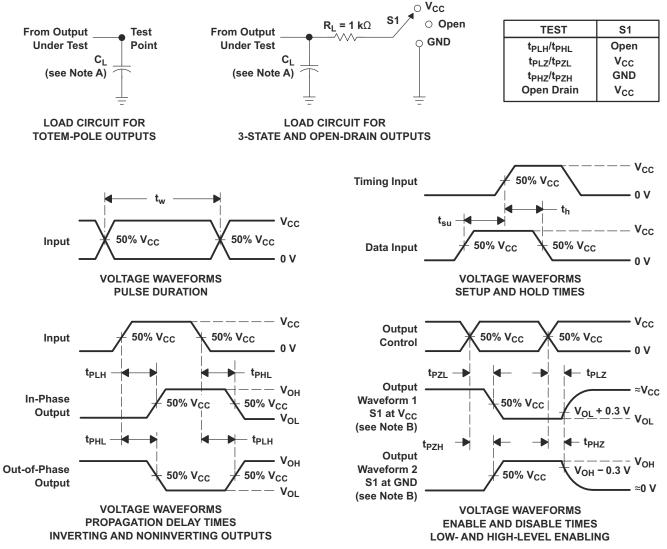


6.14 Typical Characteristics





7 Parameter Measurement Information



- A. C_L includes probe and jig capacitance.
- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, Z₀ = 50 Ω , t_r \leq 3 ns,
 - t_f ≤ 3 ns.
- D. The outputs are measured one at a time, with one input transition per measurement.
- E. t_{PLZ} and t_{PHZ} are the same as t_{dis} .
- F. t_{PZL} and t_{PZH} are the same as t_{en} .
- G. t_{PHL} and t_{PLH} are the same as t_{pd} .
- H. All parameters and waveforms are not applicable to all devices.

Figure 7-1. Load Circuit and Voltage Waveforms



8 Detailed Description

8.1 Overview

The SN74LV595A device contains an 8-bit serial-in, parallel-out shift register that feeds an 8-bit D-type storage register. The storage register has parallel 3-state outputs. Separate clocks are provided for the shift and storage registers. The shift register has a direct overriding clear (SRCLR) input, serial (SER) input, and serial outputs for cascading. When the output-enable (\overline{OE}) input is high, the outputs are in the high-impedance state. Both the shift register clock (SRCLK) and storage register clock (RCLK) are positive-edge triggered. If both clocks are connected together, then the shift register always is one clock pulse ahead of the storage register.

8.2 Functional Block Diagram

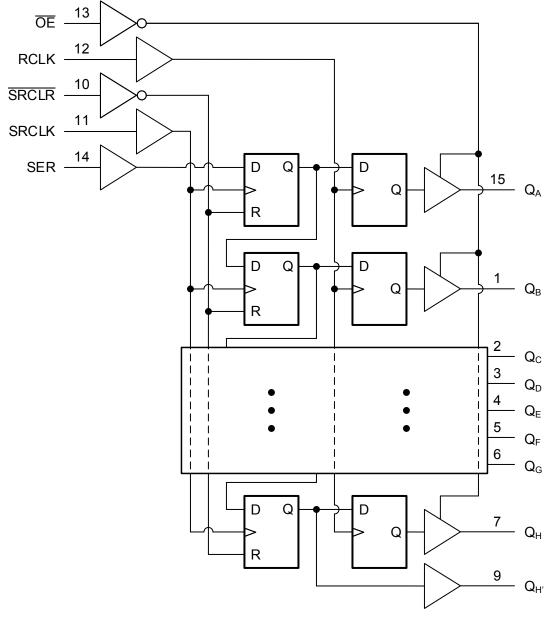


Figure 8-1. Logic Diagram (Positive Logic)



8.3 Feature Description

8.3.1 Balanced CMOS 3-State Outputs

This device includes balanced CMOS 3-state outputs. Driving high, driving low, and high impedance are the three states that these outputs can be in. The term *balanced* indicates that the device can sink and source similar currents. The drive capability of this device may create fast edges into light loads, so routing and load conditions should be considered to prevent ringing. Additionally, the outputs of this device can drive larger currents than the device can sustain without being damaged. It is important for the output power of the device to be limited to avoid damage due to overcurrent. The electrical and thermal limits defined in the *Absolute Maximum Ratings* must be followed at all times.



When placed into the high-impedance mode, the output will neither source nor sink current, with the exception of minor leakage current as defined in the *Electrical Characteristics* table. In the high-impedance state, the output voltage is not controlled by the device and is dependent on external factors. If no other drivers are connected to the node, then this is known as a floating node and the voltage is unknown. A pull-up or pull-down resistor can be connected to the output to provide a known voltage at the output while it is in the high-impedance state. The value of the resistor will depend on multiple factors, including parasitic capacitance and power consumption limitations. Typically, a $10-k\Omega$ resistor can be used to meet these requirements.

Unused 3-state CMOS outputs should be left disconnected.

8.3.2 Latching Logic

This device includes latching logic circuitry. Latching circuits commonly include D-type latches and D-type flip-flops, but include all logic circuits that act as volatile memory.

When the device is powered on, the state of each latch is unknown. There is no default state for each latch at start-up.

The output state of each latching logic circuit only remains stable as long as power is applied to the device within the supply voltage range specified in the *Recommended Operating Conditions* table.

8.3.3 Partial Power Down (I_{off})

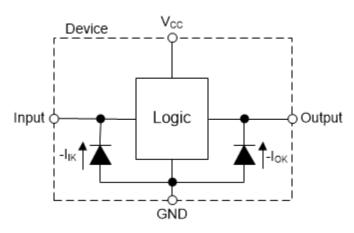
This device includes circuitry to disable all outputs when the supply pin is held at 0 V. When disabled, the outputs will neither source nor sink current, regardless of the input voltages applied. The amount of leakage current at each output is defined by the l_{off} specification in the *Electrical Characteristics* table.

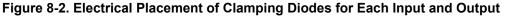
8.3.4 Clamp Diode Structure

Figure 8-2 shows the inputs and outputs to this device have negative clamping diodes only.

CAUTION

Voltages beyond the values specified in the *Absolute Maximum Ratings* table can cause damage to the device. The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.





8.4 Device Functional Modes

		INPUTS ⁽¹⁾		FUNCTION	
SER	SRCLK	SRCLR	RCLK	ŌE	FUNCTION
x	х	х	х	Н	Outputs Q _A –Q _H are disabled. Q _H Remains enabled.



Table 8-1. Function Table (continued)

		INPUTS ⁽¹⁾			FUNCTION
SER	SRCLK	SRCLR	RCLK	ŌE	FUNCTION
Х	X	Х	Х	L	Outputs Q _A –Q _H are enabled.
Х	Х	L	Х	Х	Shift register is cleared.
L	Ť	Н	х	x	First stage of the shift register goes low. Other stages store the data of previous stage, respectively.
н	1	Н	х	х	First stage of the shift register goes high. Other stages store the data of previous stage, respectively.
x	x	х	Ť	x	Shift-register data is stored in the storage register.

(1) H = High Voltage Level, L = Low Voltage Level, X = Do not Care, Z = High Impedance



9 Application and Implementation

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

9.1 Application Information

The SN74LV595A is a low-drive CMOS device that can be used for a multitude of bus interface type applications where output ringing is a concern. The low drive and slow edge rates will minimize overshoot and undershoot on the outputs. The inputs are 5-V tolerant allowing for down translation to V_{CC} .

9.2 Typical Application

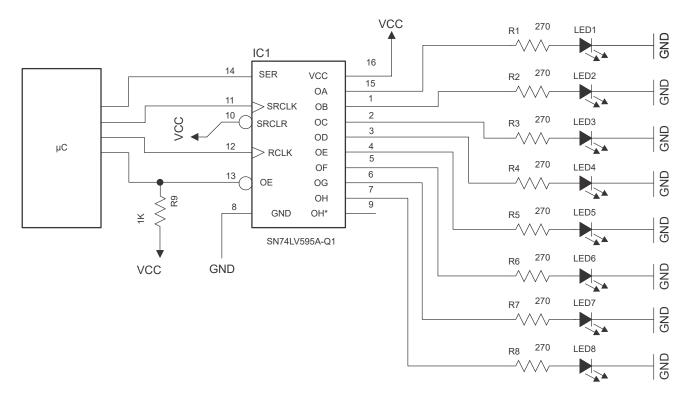


Figure 9-1. SN74LV595A Expanding IOs to Drive LEDs

9.2.1 Power Considerations

Ensure the desired supply voltage is within the range specified in the *Recommended Operating Conditions*. The supply voltage sets the device's electrical characteristics as described in the *Electrical Characteristics* section.

The positive voltage supply must be capable of sourcing current equal to the total current to be sourced by all outputs of the SN74LV595A plus the maximum static supply current, I_{CC} , listed in the *Electrical Characteristics*, and any transient current required for switching. The logic device can only source as much current that is provided by the positive supply source. Be sure to not exceed the maximum total current through V_{CC} listed in the *Absolute Maximum Ratings*.



The ground must be capable of sinking current equal to the total current to be sunk by all outputs of the SN74LV595A plus the maximum supply current, I_{CC} , listed in the *Electrical Characteristics*, and any transient current required for switching. The logic device can only sink as much current that can be sunk into its ground connection. Be sure to not exceed the maximum total current through GND listed in the *Absolute Maximum Ratings*.

The SN74LV595A can drive a load with a total capacitance less than or equal to 50 pF while still meeting all of the data sheet specifications. Larger capacitive loads can be applied; however, it is not recommended to exceed 50 pF.

The SN74LV595A can drive a load with total resistance described by $R_L \ge V_O / I_O$, with the output voltage and current defined in the *Electrical Characteristics* table with V_{OH} and V_{OL} . When outputting in the HIGH state, the output voltage in the equation is defined as the difference between the measured output voltage and the supply voltage at the V_{CC} pin.

Total power consumption can be calculated using the information provided in *CMOS Power Consumption and Cpd Calculation*.

Thermal increase can be calculated using the information provided in *Thermal Characteristics of Standard Linear* and Logic (SLL) Packages and Devices.

CAUTION

The maximum junction temperature, $T_{J(max)}$ listed in the *Absolute Maximum Ratings*, is an additional limitation to prevent damage to the device. Do not violate any values listed in the *Absolute Maximum Ratings*. These limits are provided to prevent damage to the device.

9.2.2 Input Considerations

Input signals must cross $V_{IL(max)}$ to be considered a logic LOW, and $V_{IH(min)}$ to be considered a logic HIGH. Do not exceed the maximum input voltage range found in the *Absolute Maximum Ratings*.

Unused inputs must be terminated to either V_{CC} or ground. The unused inputs can be directly terminated if the input is completely unused, or they can be connected with a pull-up or pull-down resistor if the input will be used sometimes, but not always. A pull-up resistor is used for a default state of HIGH, and a pull-down resistor is used for a default state of LOW. The drive current of the controller, leakage current into the SN74LV595A (as specified in the *Electrical Characteristics*), and the desired input transition rate limits the resistor size. A 10-k Ω resistor value is often used due to these factors.

The SN74LV595A has CMOS inputs and thus requires fast input transitions to operate correctly, as defined in the *Recommended Operating Conditions* table. Slow input transitions can cause oscillations, additional power consumption, and reduction in device reliability.

Refer to the *Feature Description* section for additional information regarding the inputs for this device.

9.2.3 Output Considerations

The positive supply voltage is used to produce the output HIGH voltage. Drawing current from the output will decrease the output voltage as specified by the V_{OH} specification in the *Electrical Characteristics*. The ground voltage is used to produce the output LOW voltage. Sinking current into the output will increase the output voltage as specified by the V_{OL} specification in the *Electrical Characteristics*.

Push-pull outputs that could be in opposite states, even for a very short time period, should never be connected directly together. This can cause excessive current and damage to the device.

Two channels within the same device with the same input signals can be connected in parallel for additional output drive strength.

Unused outputs can be left floating. Do not connect outputs directly to V_{CC} or ground.

Refer to the *Feature Description* section for additional information regarding the outputs for this device.



9.2.4 Design Requirements

This device uses CMOS technology and has balanced output drive. Care should be taken to avoid bus contention because it can drive currents that would exceed maximum limits. The high drive will also create fast edges into light loads so routing and load conditions should be considered to prevent ringing.

9.2.5 Detailed Design Procedure

- 1. Add a decoupling capacitor from V_{CC} to GND. The capacitor needs to be placed physically close to the device and electrically close to both the V_{CC} and GND pins. An example layout is shown in the *Layout* section.
- Ensure the capacitive load at the output is ≤ 50 pF. This is not a hard limit; it will, however, ensure optimal
 performance. This can be accomplished by providing short, appropriately sized traces from the SN74LV595A
 to one or more of the receiving devices.
- 3. Ensure the resistive load at the output is larger than $(V_{CC} / I_{O(max)}) \Omega$. This will ensure that the maximum output current from the *Absolute Maximum Ratings* is not violated. Most CMOS inputs have a resistive load measured in M Ω ; much larger than the minimum calculated previously.
- 4. Thermal issues are rarely a concern for logic gates; the power consumption and thermal increase, however, can be calculated using the steps provided in the application report, *CMOS Power Consumption and Cpd Calculation*.

9.2.6 Application Curves

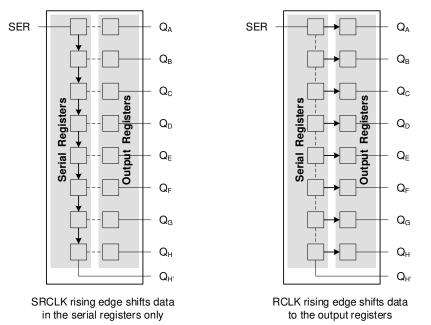


Figure 9-2. Simplified Functional Diagram Showing Clock Operation

9.3 Power Supply Recommendations

The power supply can be any voltage between the MIN and MAX supply voltage rating located in the *Recommended Operating Conditions* table.

Each V_{CC} terminal should have a good bypass capacitor to prevent power disturbance. For devices with a single supply, a 0.1 μ F capacitor is recommended. If there are multiple V_{CC} terminals then 0.01 μ F or 0.022 μ F capacitors are recommended for each power terminal. It is ok to parallel multiple bypass capacitors to reject different frequencies of noise. 0.1 μ F and 1.0 μ F capacitors are commonly used in parallel. The bypass capacitor should be installed as close to the power terminal as possible for the best results.



9.4 Layout

9.4.1 Layout Guidelines

When using multiple bit logic devices, inputs should not float. In many cases, functions or parts of functions of digital logic devices are unused. Some examples are when only two inputs of a triple-input AND gate are used, or when only 3 of the 4-buffer gates are used. Such unused input pins must not be left unconnected because the undefined voltages at the outside connections result in undefined operational states. All unused inputs of digital logic devices must be connected to a logic high or logic low voltage, as defined by the input voltage specifications, to prevent them from floating. The logic level that must be applied to any particular unused input depends on the function of the device. Generally, the inputs are tied to GND or VCC, whichever makes more sense for the logic function or is more convenient.

9.4.2 Layout Example

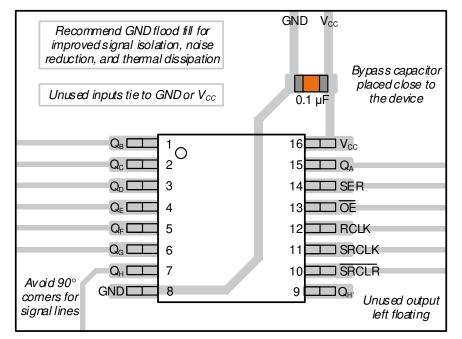


Figure 9-3. Layout Example for the SN74LV595A in TSSOP



10 Device and Documentation Support

10.1 Documentation Support

10.1.1 Related Documentation

For related documentation, see the following:

- · Texas Instruments, CMOS Power Consumption and Cpd Calculation application report
- Texas Instruments, Thermal Characteristics of Standard Linear and Logic (SLL) Packages and Devices appliation report

10.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Subscribe to updates* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

10.3 Support Resources

TI E2E[™] support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

10.4 Trademarks

TI E2E[™] is a trademark of Texas Instruments.

All trademarks are the property of their respective owners.

10.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

10.6 Glossary

TI Glossary This glossary lists and explains terms, acronyms, and definitions.

11 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
SN74LV595ABQBR	ACTIVE	WQFN	BQB	16	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LV595A	Samples
SN74LV595AD	OBSOLETE	SOIC	D	16		TBD	Call TI	Call TI	-40 to 125	LV595A	
SN74LV595ADR	ACTIVE	SOIC	D	16	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LV595A	Samples
SN74LV595ADRG3	ACTIVE	SOIC	D	16	2500	RoHS & Green	SN	Level-1-260C-UNLIM	-40 to 125	LV595A	Samples
SN74LV595ADRG4	ACTIVE	SOIC	D	16	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LV595A	Samples
SN74LV595ANSR	ACTIVE	SOP	NS	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	74LV595A	Samples
SN74LV595APWR	ACTIVE	TSSOP	PW	16	2000	RoHS & Green	NIPDAU SN	Level-1-260C-UNLIM	-40 to 125	LV595A	Samples
SN74LV595APWRG3	ACTIVE	TSSOP	PW	16	2000	RoHS & Green	SN	Level-1-260C-UNLIM	-40 to 125	LV595A	Samples
SN74LV595APWRG4	ACTIVE	TSSOP	PW	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LV595A	Samples
SN74LV595APWT	OBSOLETE	TSSOP	PW	16		TBD	Call TI	Call TI	-40 to 125	LV595A	
SN74LV595ARGYR	ACTIVE	VQFN	RGY	16	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LV595A	Samples
SN74LV595ARGYRG4	ACTIVE	VQFN	RGY	16	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LV595A	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.



www.ti.com

PACKAGE OPTION ADDENDUM

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

⁽⁵⁾ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF SN74LV595A :

- Automotive : SN74LV595A-Q1
- Enhanced Product : SN74LV595A-EP

NOTE: Qualified Version Definitions:

- Automotive Q100 devices qualified for high-reliability automotive applications targeting zero defects
- Enhanced Product Supports Defense, Aerospace and Medical Applications

www.ti.com

Texas

NSTRUMENTS

TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



Deview	Destant	De altra era	Dive	0.00	Deal	Bud			140			Divid
Device	Раскаде Туре	Package Drawing	Pins	SPQ	Reel Diameter	Reel Width	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
					(mm)	W1 (mm)						
SN74LV595ABQBR	WQFN	BQB	16	3000	180.0	12.4	2.8	3.8	1.2	4.0	12.0	Q1
SN74LV595ADR	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1
SN74LV595ADRG3	SOIC	D	16	2500	330.0	16.8	6.5	10.3	2.1	8.0	16.0	Q1
SN74LV595ADRG4	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1
SN74LV595ANSR	SOP	NS	16	2000	330.0	16.4	8.2	10.5	2.5	12.0	16.0	Q1
SN74LV595APWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74LV595APWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74LV595APWRG3	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74LV595APWRG4	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74LV595APWRG4	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74LV595ARGYR	VQFN	RGY	16	3000	330.0	12.4	3.8	4.3	1.5	8.0	12.0	Q1



www.ti.com

PACKAGE MATERIALS INFORMATION

7-Dec-2024



All dimensions are nominal	î	<u>, </u>					
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74LV595ABQBR	WQFN	BQB	16	3000	210.0	185.0	35.0
SN74LV595ADR	SOIC	D	16	2500	353.0	353.0	32.0
SN74LV595ADRG3	SOIC	D	16	2500	364.0	364.0	27.0
SN74LV595ADRG4	SOIC	D	16	2500	340.5	336.1	32.0
SN74LV595ANSR	SOP	NS	16	2000	356.0	356.0	35.0
SN74LV595APWR	TSSOP	PW	16	2000	356.0	356.0	35.0
SN74LV595APWR	TSSOP	PW	16	2000	353.0	353.0	32.0
SN74LV595APWRG3	TSSOP	PW	16	2000	364.0	364.0	27.0
SN74LV595APWRG4	TSSOP	PW	16	2000	353.0	353.0	32.0
SN74LV595APWRG4	TSSOP	PW	16	2000	356.0	356.0	35.0
SN74LV595ARGYR	VQFN	RGY	16	3000	360.0	360.0	36.0

NS0016A



PACKAGE OUTLINE

SOP - 2.00 mm max height

SOP



NOTES:

- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing
- Per ASME Y14.5M.
 This drawing is subject to change without notice.
 This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm, per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm, per side.



NS0016A

EXAMPLE BOARD LAYOUT

SOP - 2.00 mm max height

SOP



NOTES: (continued)

5. Publication IPC-7351 may have alternate designs.

6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



NS0016A

EXAMPLE STENCIL DESIGN

SOP - 2.00 mm max height

SOP



NOTES: (continued)

7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

8. Board assembly site may have different recommendations for stencil design.



D (R-PDSO-G16)

PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AC.



PW0016A



PACKAGE OUTLINE

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



PW0016A

EXAMPLE BOARD LAYOUT

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



PW0016A

EXAMPLE STENCIL DESIGN

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

9. Board assembly site may have different recommendations for stencil design.



^{8.} Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

MECHANICAL DATA

PLASTIC SMALL-OUTLINE PACKAGE

0,51 0,35 ⊕0,25⊛ 1,27 8 14 0,15 NOM 5,60 8,20 5,00 7,40 \bigcirc Gage Plane ₽ 0,25 7 1 1,05 0,55 0-10 Δ 0,15 0,05 Seating Plane — 2,00 MAX 0,10PINS ** 14 16 20 24 DIM 10,50 10,50 12,90 15,30 A MAX A MIN 9,90 9,90 12,30 14,70 4040062/C 03/03

NOTES: A. All linear dimensions are in millimeters.

NS (R-PDSO-G**)

14-PINS SHOWN

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



BQB 16

GENERIC PACKAGE VIEW

WQFN - 0.8 mm max height

PLASTIC QUAD FLATPACK - NO LEAD

2.5 x 3.5, 0.5 mm pitch

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.





BQB0016A

PACKAGE OUTLINE

WQFN - 0.8 mm max height

PLASTIC QUAD FLAT PACK-NO LEAD



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. The package thermal pad must be soldered to the printed circuit board for optimal thermal and mechanical performance.



BQB0016A

EXAMPLE BOARD LAYOUT

WQFN - 0.8 mm max height

PLASTIC QUAD FLAT PACK-NO LEAD



NOTES: (continued)

- 4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).
- 5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.

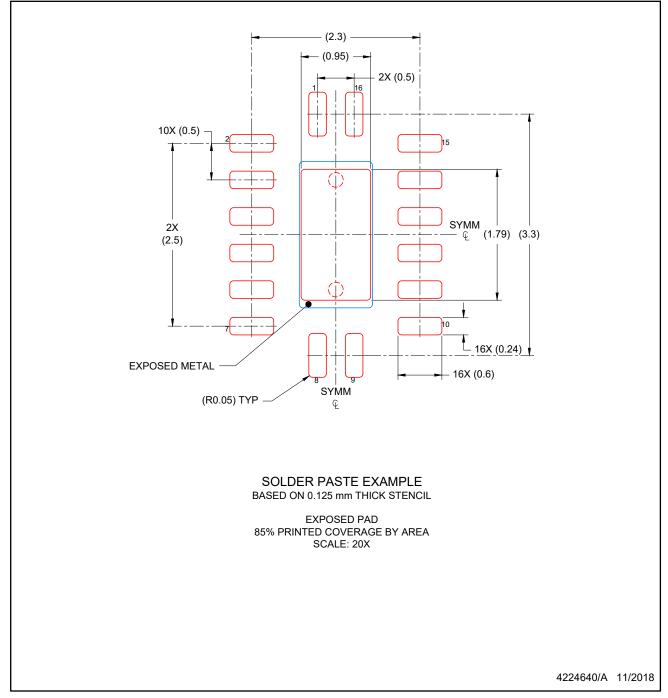


BQB0016A

EXAMPLE STENCIL DESIGN

WQFN - 0.8 mm max height

PLASTIC QUAD FLAT PACK-NO LEAD

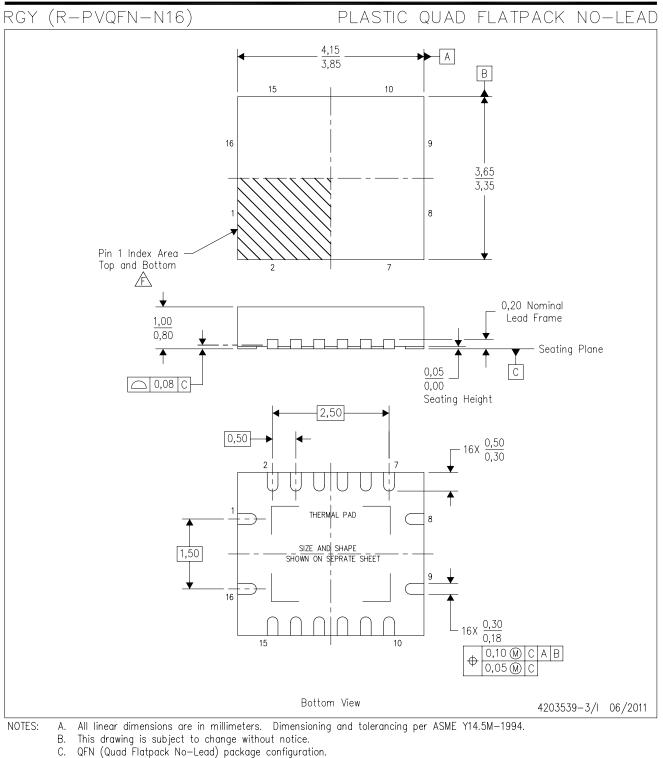


NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



MECHANICAL DATA



D. The package thermal pad must be soldered to the board for thermal and mechanical performance.

- E. See the additional figure in the Product Data Sheet for details regarding the exposed thermal pad features and dimensions.
- earrow Pin 1 identifiers are located on both top and bottom of the package and within the zone indicated.
- The Pin 1 identifiers are either a molded, marked, or metal feature.
- G. Package complies to JEDEC MO-241 variation BA.



IMPORTANT NOTICE AND DISCLAIMER

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATA SHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, regulatory or other requirements.

These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you will fully indemnify TI and its representatives against, any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI's products are provided subject to TI's Terms of Sale or other applicable terms available either on ti.com or provided in conjunction with such TI products. TI's provision of these resources does not expand or otherwise alter TI's applicable warranties or warranty disclaimers for TI products.

TI objects to and rejects any additional or different terms you may have proposed.

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265 Copyright © 2025, Texas Instruments Incorporated